

Depletion-Mode Power MOSFET

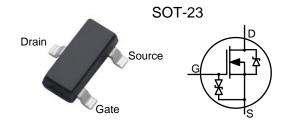
General Features

- ➤ ESD improved Capability
- Depletion Mode (Normally On)
- Proprietary Advanced Planar Technology
- Rugged Polysilicon Gate Cell Structure
- > Fast Switching Speed
- > RoHS Compliant
- ➤ Halogen-free available

Applications

- Normally-on Switches
- > SMPS Start-up Circuit
- Linear Amplifier
- Converters
- Constant Current Source
- > Telecom

| BV _{DSX} | R _{DS(ON)} (Max.) | $I_{ m DSS,min}$ | | |
|-------------------|----------------------------|------------------|--|--|
| 600V | 700 Ω | 5mA | | |



Ordering Information

| Part Number | Package | Marking | Remark |
|-------------|---------|---------|--------------|
| DMZ6005E | SOT-23 | 605E | Halogen Free |

Absolute Maximum Ratings

TA =25°C unless otherwise specified

| Symbol | Parameter | DMZ6005E | Unit |
|-------------------------------------|--|------------|------|
| V_{DSX} | Drain-to-Source Voltage ^[1] | 600 | V |
| V _{DGX} | Drain-to-Gate Voltage ^[1] | 600 | V |
| I_D | Continuous Drain Current | 0.02 | ٨ |
| I_{DM} | Pulsed Drain Current ^[2] | 0.08 | A |
| P_D | Power Dissipation | 0.50 | W |
| V_{GS} | Gate-to-Source Voltage | ±20 | V |
| T_{L} | Soldering Temperature Distance of 1.6mm from case for 10 seconds | 300 | °C |
| T_{J} and T_{STG} | Operating and Storage Temperature Range | -55 to 150 | |

Caution: Stresses greater than those listed in the "Absolute Maximum Ratings" may cause permanent damage to the device.

Thermal Characteristics

| Symbol | Parameter | DMZ6005E | Unit |
|----------------|---|----------|------|
| $R_{	heta JA}$ | Thermal Resistance, Junction-to-Ambient | 250 | K/W |



Electrical Characteristics

OFF Characteristics

TA =25°C unless otherwise specified

| Symbol | Parameter | Min. | Тур. | Max. | Unit | Test Conditions |
|--------------|-----------------------------------|------|------|------|------|---|
| BV_{DSX} | Drain-to-Source Breakdown Voltage | 600 | | | V | V_{GS} =-5V, I_D =250 μ A |
| $I_{D(OFF)}$ | Drain-to-Source Leakage Current | | | 0.1 | μΑ | $V_{DS} = 600V$, $V_{GS} = -5V$ |
| | | | | 10 | μΑ | V_{DS} =600V, V_{GS} = -5V T_J =125°C |
| I_{GSS} | Gate-to-Source Leakage Current | | | 20 | | $V_{GS} = +20V, V_{DS} = 0V$ |
| | | | | -20 | μΑ | V_{GS} =-20V, V_{DS} =0V |

ON Characteristics

TA =25°C unless otherwise specified

| Symbol | Parameter | Min. | Тур. | Max. | Unit | Test Conditions |
|----------------------|--------------------------------------|------|------|------|------|---|
| I_{DSS} | Saturated Drain-to-Source Current | 5 | | 25 | mA | V _{GS} =0V, V _{DS} =25V |
| R _{DS(ON)} | Static Drain-to-Source On-Resistance | | 500 | 700 | Ω | $V_{GS}=0V$, $I_{D}=3mA^{[3]}$ |
| V _{GS(OFF)} | Gate-to-Source Cut-off Voltage | -3.3 | | -1.5 | V | $V_{DS} = 3V, I_{D} = 8 \mu A$ |
| gfs | Forward Transconductance | | 15.4 | | mS | $V_{DS} = 10V$, $I_D = 5mA$ |

Dynamic Characteristics

Essentially independent of operating temperature

| Symbol | Parameter | Min. | Тур. | Max. | Unit | Test Conditions |
|-------------------|-------------------------------|------|------|------|------|--|
| C_{ISS} | Input Capacitance | | 12.3 | | pF | $\begin{array}{l} V_{GS}{=}{-}5V \\ V_{DS}{=}25V \\ f{=}1.0MH_Z \end{array}$ |
| Coss | Oput Capacitance | | 2.6 | | | |
| C_{RSS} | Reverse Transfer Capacitance | | 1.8 | | | |
| Q_{G} | Total Gate Charge | | 1.55 | | | |
| Q_{GS} | Gate-to-Source Charge | | 0.12 | | nC | V_{GS} =-5V~5V V_{DS} =300V, I_D =7mA |
| Q_{GD} | Gate-to-Drain (Miller) Charge | | 0.56 | | | |

Resistive Switching Characteristics

Essentially independent of operating temperature

| Symbol | Parameter | Min. | Тур. | Max. | Unit | Test Conditions |
|---------------------|---------------------|------|------|------|------|---|
| $t_{d(ON)}$ | Turn-on Delay Time | | 4 | | | |
| t _{rise} | Rise Time | | 9 | | no | $V_{GS} = -5V \sim 5V$ |
| t _{d(OFF)} | Turn-off Delay Time | | 14 | | ns | $V_{DD} = 300V, I_D = 7mA$ $R_G = 20 \Omega$ |
| t _{fall} | Fall Time | | 84 | | | |



Source-Drain Diode Characteristics

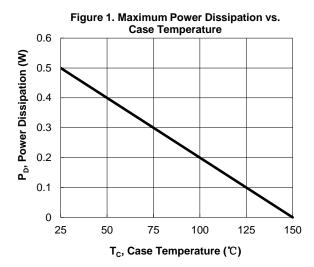
TA =25°C unless otherwise specified

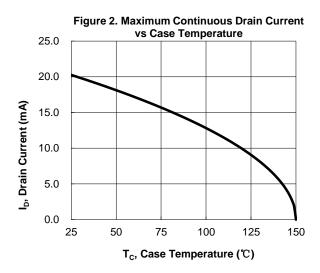
| Symbol | Parameter | Min | Тур. | Max. | Units | Test Conditions |
|----------|-----------------------|-----|------|------|-------|---|
| V_{SD} | Diode Forward Voltage | | 1 | 1.2 | V | $I_{SD} = 3.0 \text{ mA}, V_{GS} = -10 \text{ V}$ |

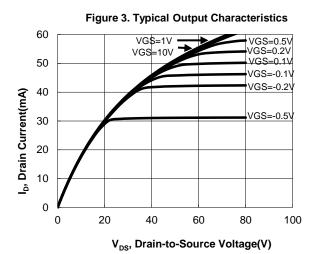
NOTE:

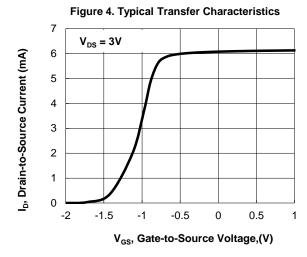
- [1] $T_J = +25^{\circ}C$ to $+150^{\circ}C$
- [2] Repetitive rating, pulse width limited by maximum junction temperature.
- [3] Pulse width \le 380 \mus; duty cycle \le 2%.

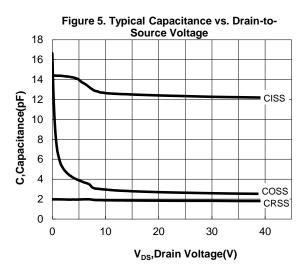




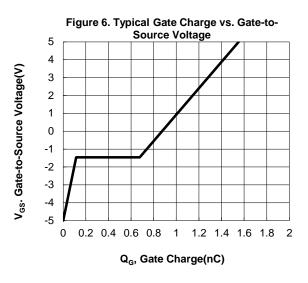








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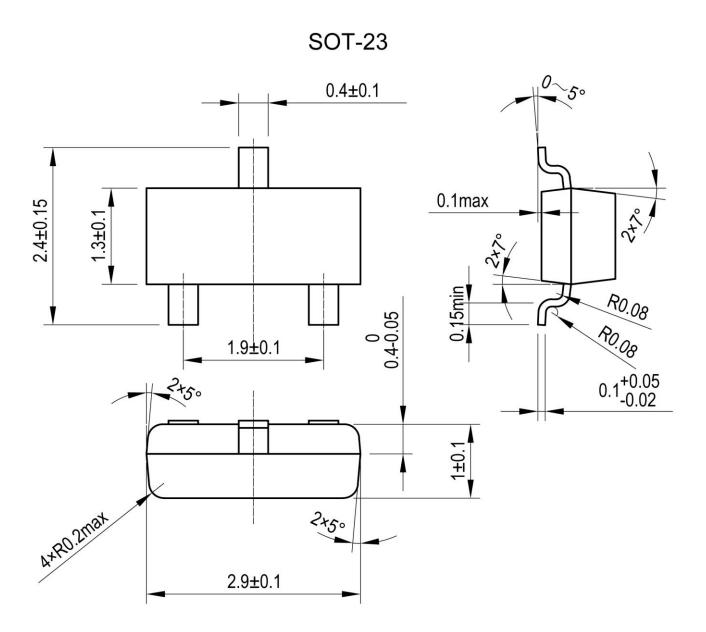


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Package Dimensions





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